

<b>U.S. Department of Commerce</b>  <b>INFORMATION DISCLOSURE CITATION</b> <b>IN AN APPLICATION</b> <i>(Use several sheets if necessary)</i>	<b>ATTY. DOCKET NO.</b> <b>DKC 1060</b>	<b>SERIAL NO.:</b> <b>10 529 327</b>
	<b>APPLICANT:</b> <b>HONG ET AL</b>	
	<b>FILING DATE:</b> <b>MARCH 25, 2005</b>	<b>GROUP:</b> <b>1714</b>

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/PS/	2006 0183826	08/17/2006	Ryu et al.			02/06/2006
/PS/	2006 0189729	08/24/2006	Bae et al.			02/14/2006
/PS/	2006 0189730	08/24/2006	Hong et al.			02/14/2006
/PS/	2007 0032579	02/08/2007	Ku et al.			05/02/2006
/PS/	6 262 166	07/17/2001	Yoshida et al.			
/PS/	4 397 759	08/09/1983	Hancock			

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
/PS/	JP 61-009450	01/17/1986	Japan				X


EXAMINER INITIALS	OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
/PS/ ↓ /PS/	Abstract of published Japanese Application 61-009450 published January 17, 1986 Copy of unpublished U.S. Serial No. 11 601 352 filed November 17, 2006 for Ku et al. Abstract of Korean Publication No. KR 2004 0058773 published July 5, 2004 Abstract of Korean Publication No. KR 2004 0027104 published April 1, 2004 Abstract of Korean Publication No. KR 2003 0030421 published April 18, 2003 Abstract of Korean Publication No. KR 2001 0009848 published February 5, 2001 Abstract of Korean Publication No. KR 2001 0083602 published September 1, 2001	
EXAMINER	/Peter Szekely/	DATE CONSIDERED 07/03/2007

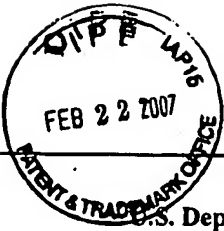
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EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/PS/	3 639 506	05/21/1969	Haaf			
/PS/	3 789 901	02/05/1974	Rishovd			
/PS/	3 849 368	11/19/1974	Anderson et al.			
/PS/	3 883 613	05/13/1975	Cooper			
/PS/	4 273 881	06/16/1981	Otten			
/PS/	4 526 917	07/02/1985	Axelrod			
/PS/	5 710 305	01/20/1998	Archer et al.			
/PS/	5 859 147	01/12/1999	Dalla Torre et al.			

EXAMINER INITIALS	OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
/PS/  /PS/	Abstract of Korean Publication No. KR 2004 0003563 published January 13, 2004 Abstract of Korean Publication No. KR 2003 0078189 published October 8, 2003 Abstract of Japanese Publication No. JP 11343382 published Dec. 14, 1999 Abstract of Japanese Publication No. JP 10195287 published July 28, 1998 Abstract of Japanese Publication No. JP 60079048 published May 4, 1985 Abstract of Japanese Publication No. JP 1140270 published May 25, 1999 Abstract of Japanese Publication No. JP 2001040172 published Feb. 13, 2001 Abstract of WO 98 11160 published March 19, 1998 Abstract of WO 00 17268 published March 30, 2000	
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/PS/	2006 0183825	08/17/2006	Ahn et al.			02/06/2006

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